

### General Description

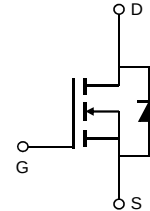
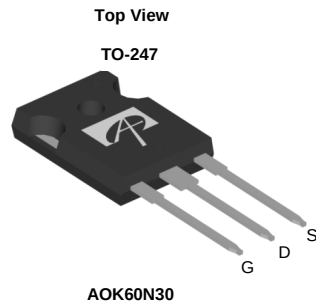
The AOK60N30 is fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low  $R_{DS(on)}$ ,  $C_{iss}$  and  $C_{rss}$  along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs.

For Halogen Free add "L" suffix to part number:  
AOK60N30L

### Product Summary

|                                 |           |
|---------------------------------|-----------|
| $V_{DS}$                        | 350@150°C |
| $I_D$ (at $V_{GS}=10V$ )        | 60A       |
| $R_{DS(on)}$ (at $V_{GS}=10V$ ) | < 0.056Ω  |

100% UIS Tested  
100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                                                    | Symbol         | AOK60N30   | Units |
|------------------------------------------------------------------------------|----------------|------------|-------|
| Drain-Source Voltage                                                         | $V_{DS}$       | 300        | V     |
| Gate-Source Voltage                                                          | $V_{GS}$       | ±30        | V     |
| Continuous Drain Current                                                     | $I_D$          | 60         | A     |
| $T_C=25^\circ\text{C}$                                                       |                | 40         |       |
| Pulsed Drain Current <sup>C</sup>                                            | $I_{DM}$       | 200        | A     |
| Avalanche Current <sup>C</sup>                                               | $I_{AR}$       | 9.5        | A     |
| Repetitive avalanche energy <sup>C</sup>                                     | $E_{AR}$       | 1353       | mJ    |
| Single plused avalanche energy <sup>G</sup>                                  | $E_{AS}$       | 2707       | mJ    |
| Peak diode recovery dv/dt                                                    | dv/dt          | 5          | V/ns  |
| Power Dissipation <sup>B</sup>                                               | $P_D$          | 658        | W     |
| $T_C=25^\circ\text{C}$                                                       |                | 5.3        | W/°C  |
| Derate above 25°C                                                            |                |            |       |
| Junction and Storage Temperature Range                                       | $T_J, T_{STG}$ | -55 to 150 | °C    |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds | $T_L$          | 300        | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol          | AOK60N30 | Units |
|--------------------------------------------|-----------------|----------|-------|
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JA}$ | 40       | °C/W  |
| Maximum Case-to-sink <sup>A</sup>          | $R_{\theta CS}$ | 0.5      | °C/W  |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 0.19     | °C/W  |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                                | Parameter                             | Conditions                                                                               | Min  | Typ   | Max   | Units |
|---------------------------------------|---------------------------------------|------------------------------------------------------------------------------------------|------|-------|-------|-------|
| <b>STATIC PARAMETERS</b>              |                                       |                                                                                          |      |       |       |       |
| BV <sub>DSS</sub>                     | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                         | 300  |       |       | V     |
|                                       |                                       | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C                        |      | 350   |       |       |
| BV <sub>DSS</sub><br>/ΔT <sub>J</sub> | Zero Gate Voltage Drain Current       | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                               |      | 0.26  |       | V/°C  |
| I <sub>DSS</sub>                      | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =300V, V <sub>GS</sub> =0V                                               |      |       | 1     | μA    |
|                                       |                                       | V <sub>DS</sub> =240V, T <sub>J</sub> =125°C                                             |      |       | 10    |       |
| I <sub>GSS</sub>                      | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V                                               |      |       | ±100  | nA    |
| V <sub>GS(th)</sub>                   | Gate Threshold Voltage                | V <sub>DS</sub> =5V, I <sub>D</sub> =250μA                                               | 2.9  | 3.5   | 4.1   | V     |
| R <sub>DS(ON)</sub>                   | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =30A                                                |      | 0.042 | 0.056 | Ω     |
| g <sub>FS</sub>                       | Forward Transconductance              | V <sub>DS</sub> =40V, I <sub>D</sub> =30A                                                |      | 52    |       | S     |
| V <sub>SD</sub>                       | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                  |      | 0.68  | 1     | V     |
| I <sub>S</sub>                        | Maximum Body-Diode Continuous Current |                                                                                          |      |       | 60    | A     |
| I <sub>SM</sub>                       | Maximum Body-Diode Pulsed Current     |                                                                                          |      |       | 200   | A     |
| <b>DYNAMIC PARAMETERS</b>             |                                       |                                                                                          |      |       |       |       |
| C <sub>iss</sub>                      | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz                                        | 3550 | 4438  | 5330  | pF    |
| C <sub>oss</sub>                      | Output Capacitance                    |                                                                                          | 410  | 593   | 770   | pF    |
| C <sub>rss</sub>                      | Reverse Transfer Capacitance          |                                                                                          | 22   | 38    | 54    | pF    |
| R <sub>g</sub>                        | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                         | 0.8  | 1.7   | 2.6   | Ω     |
| <b>SWITCHING PARAMETERS</b>           |                                       |                                                                                          |      |       |       |       |
| Q <sub>g</sub>                        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =240V, I <sub>D</sub> =60A                         | 70   | 88    | 106   | nC    |
| Q <sub>gs</sub>                       | Gate Source Charge                    |                                                                                          |      | 21    |       | nC    |
| Q <sub>gd</sub>                       | Gate Drain Charge                     |                                                                                          |      | 28    |       | nC    |
| t <sub>D(on)</sub>                    | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =150V, I <sub>D</sub> =60A,<br>R <sub>G</sub> =25Ω |      | 88    |       | ns    |
| t <sub>r</sub>                        | Turn-On Rise Time                     |                                                                                          |      | 222   |       | ns    |
| t <sub>D(off)</sub>                   | Turn-Off DelayTime                    |                                                                                          |      | 224   |       | ns    |
| t <sub>f</sub>                        | Turn-Off Fall Time                    |                                                                                          |      | 132   |       | ns    |
| t <sub>rr</sub>                       | Body Diode Reverse Recovery Time      | I <sub>F</sub> =60A, dI/dt=100A/μs, V <sub>DS</sub> =100V                                | 250  | 320   | 390   | ns    |
| Q <sub>rr</sub>                       | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =60A, dI/dt=100A/μs, V <sub>DS</sub> =100V                                | 11   | 14.5  | 18    | μC    |

A. The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25° C.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. L=60mH, I<sub>AS</sub>=9.5A, V<sub>DD</sub>=150V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25° C

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# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

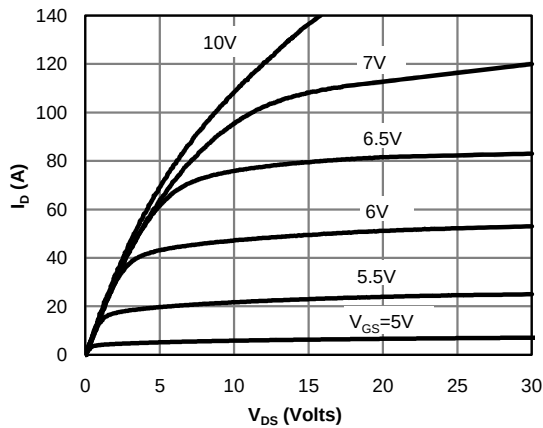


Fig 1: On-Region Characteristics

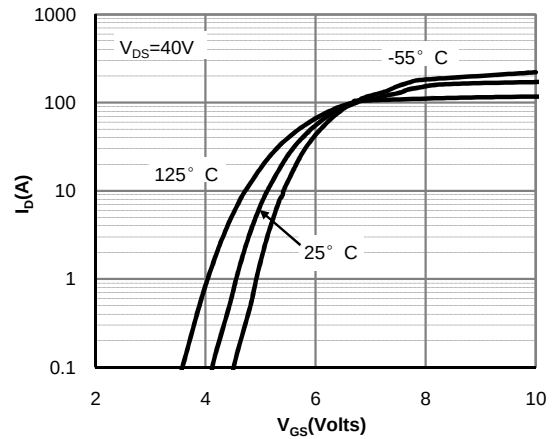


Figure 2: Transfer Characteristics

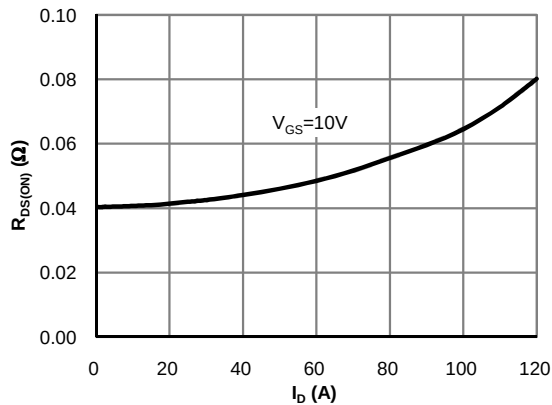


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

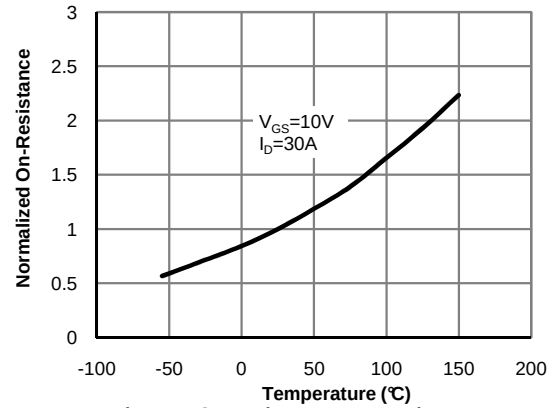


Figure 4: On-Resistance vs. Junction Temperature

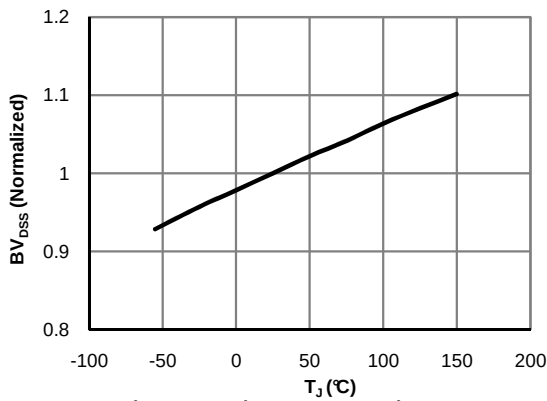


Figure 5: Break Down vs. Junction Temperature

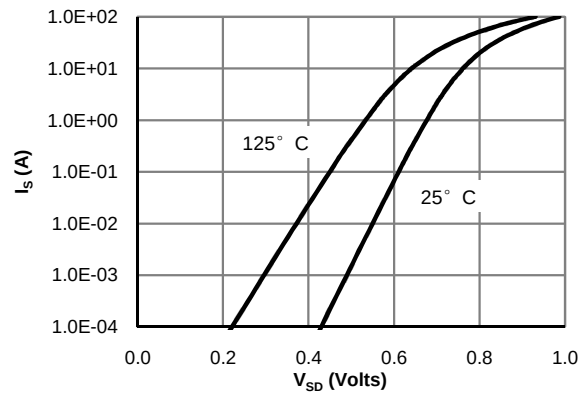
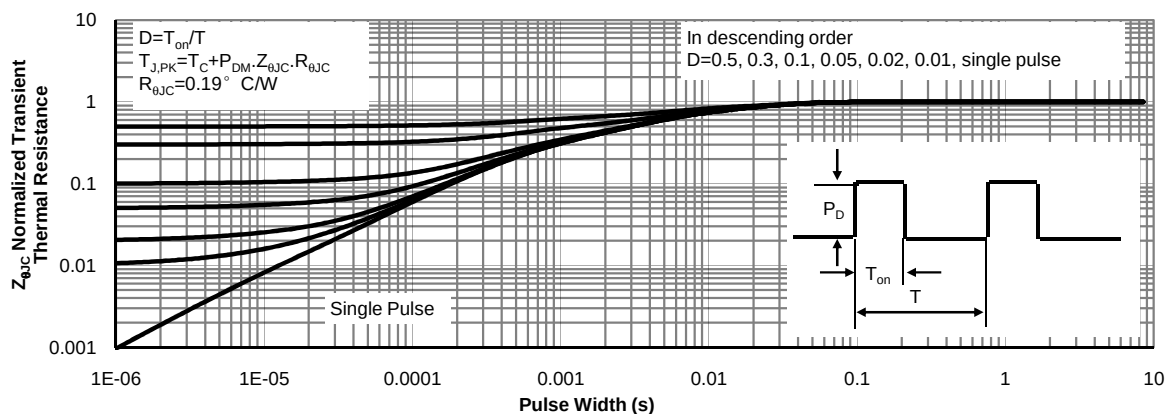
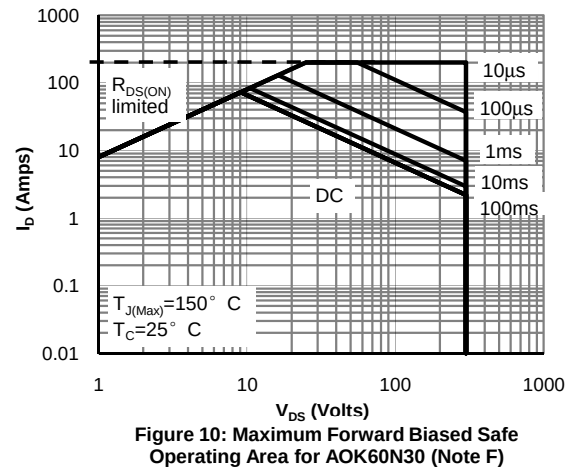
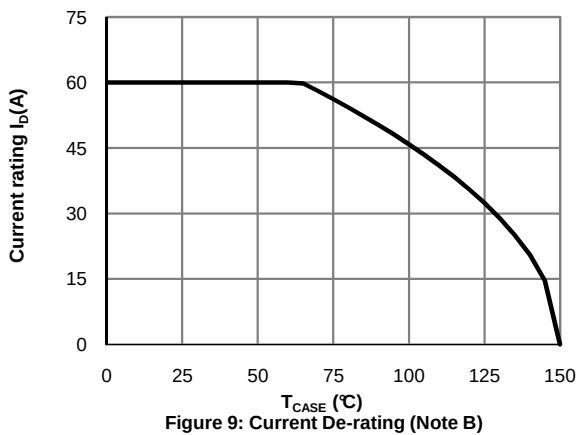
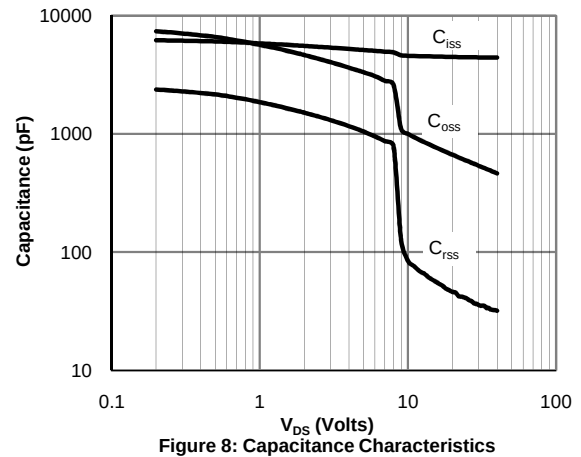
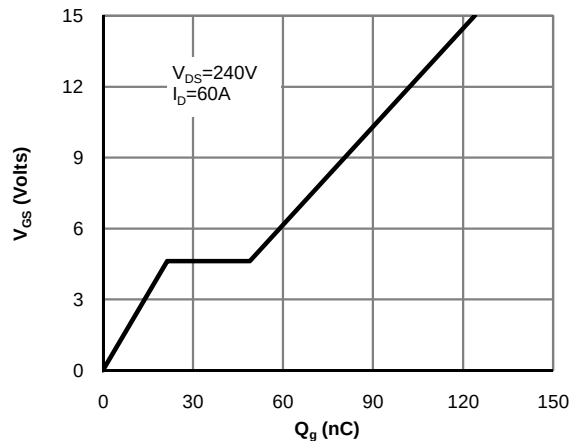
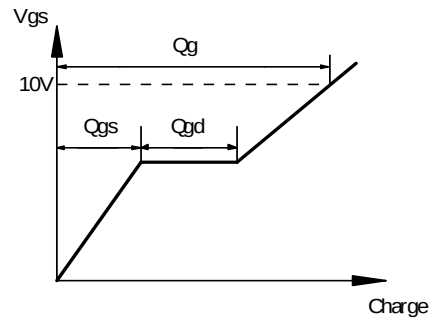
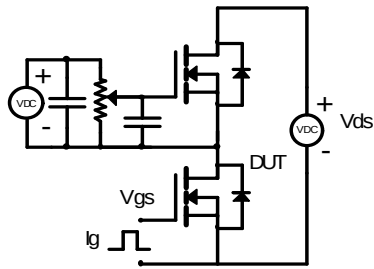


Figure 6: Body-Diode Characteristics (Note E)

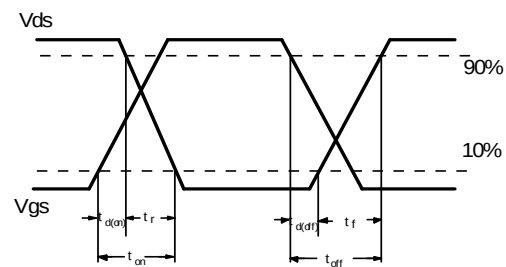
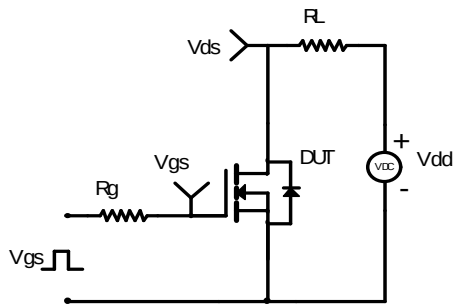
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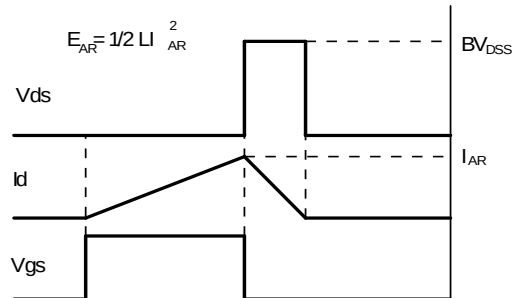
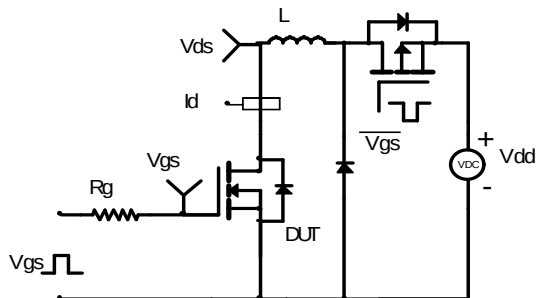
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

